

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination MICHON ET AL.	
			Examiner S. Devi, Ph.D.	Art Unit 1645	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0048929	12-2001	CHONG et al.	424/234.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Que et al. In: Abstracts of the 93rd General Meeting of American Society for Microbiology, Atlanta, Georgia, 16-20 May 1993, page 156, #E-81
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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